Figure 1

(a) Al Contact
   BCP
   Substrate (Si or ITO)
   1.28 nm

(b) Al Contact
   BCP
   Substrate (Si or ITO)
   1.28 nm

(c) Al Contact
   BCP
   Substrate (Si or ITO)
   1.28 nm
Figure 4
Figure 5
Figure 7

(a) Image with color gradient indicating carbon mass percentage. Scale bar: 20 nm.

(b) Graph showing carbon composition (mass-%) versus distance (nm). Peaks at Bulk C_{60} and Bulk CuPc.

(c) Image with RMS roughness value of 1.5 nm. Scale bar: 200 nm.

(d) Graphs of height from mean (nm) with EDX and AFM RMS values of 1.3 nm.
Figure 8

a) $\Phi = 0.2^\circ$

1 keV

Pt

Film

Sub: 3.5 eV

b) $\Phi = 7^\circ$

1 keV

Pt

Film

Sub: 122 eV